

# **80V N-Channel Trench MOSFET**

Features		Product Summary			
Trench Power Technology		Vds			
• Low R <sub>DS(ON)</sub>					
Low Gate Charge	$R_{DS(ON)}$ (at V <sub>GS</sub> =10V) < 4.5m $\Omega$				
Optimized for Fast-switching Applicati	ons	I <sub>D</sub> (at V <sub>GS</sub> =10V)	V <sub>GS</sub> =10V) 160A		
		100% UIS Tested			
Applications					
• Synchronous Rectification in DC/DC	and AC/DC Converters				
<ul> <li>Isolated DC/DC Converters in Telecor</li> </ul>	n and Industrial		RoF	15	
G D S	TO-220 G p s		Drain Gate		
Device	Packa	Marking	Marking		
TMB160N08A	TO-263		160N08A		
TMP160N08A	TO-2	20	160N08A		
Absolute Maximum Ratings	Γ <sub>C</sub> = 25ºC, unless α	otherwise noted			
Parameter		Symbol	Value	Unit	
Drain-Source Voltage (V <sub>GS</sub> = 0V)		V <sub>DSS</sub>	80	V	
Continuous Dania Current	T <sub>C</sub> = 25°C		160		
Continuous Drain Current	T <sub>C</sub> = 100°C	I I <sub>D</sub>	112	A	
Pulsed Drain Current (note1)		I <sub>DM</sub>	640	A	
Gate-Source Voltage		V <sub>GSS</sub>	±20	V	
Single Pulse Avalanche Energy (note2)		E <sub>AS</sub>	960	mJ	
Avalanche Current		I <sub>As</sub>	80	A	
Power Dissinction (note2)	T <sub>C</sub> = 25°C	P	283	W	
Power Dissipation (note3)	T <sub>C</sub> = 100°C	P <sub>D</sub>	141	W	
Operating Junction and Storage Temperation	ture Range	T <sub>J</sub> , T <sub>stg</sub>	-55~+175	°C	
Operating Junction and Storage Temperation Thermal Resistance	ture Range	T <sub>J</sub> , T <sub>stg</sub>	-55~+175		
	ture Range	T <sub>J</sub> , T <sub>stg</sub>	-55~+175 Value	Unit	
Thermal Resistance	ture Range				

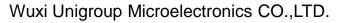


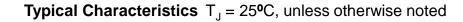
Specifications T <sub>J</sub> = 25°C, u	unless othe	rwise noted					
			Value				
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	-		-				
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0V, I_{D} = 250 \mu A$	80			V	
Zero Gate Voltage Drain Current		$V_{DS} = 80V, V_{GS} = 0V, T_{J} = 25^{\circ}C$			1		
	I <sub>DSS</sub>	V <sub>DS</sub> = 80V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 100°C			25	μA	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{GS}$ = $\pm 20V$			±100	nA	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2		4	V	
Drain-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 30A		3.7	4.5	mΩ	
Forward Transconductance	9 <sub>fs</sub>	$V_{DS} = 5V, I_{D} = 20A$	60			S	
Dynamic	-	•	-				
Input Capacitance	C <sub>iss</sub>	- V <sub>GS</sub> = 0V,		9000		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 40V$ ,		520			
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0MHz		350			
Total Gate Charge	Qg			180		nC	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DD} = 40V, I_{D} = 20A, V_{GS} = 10V$		32			
Gate-Drain Charge	Q <sub>gd</sub>			66			
Turn-on Delay Time	t <sub>d(on)</sub>			38		ns	
Turn-on Rise Time	t <sub>r</sub>	V <sub>DD</sub> = 40V, I <sub>D</sub> = 2A,		40			
Turn-off Delay Time	t <sub>d(off)</sub>	$R_{\rm G} = 2.5\Omega$		56			
Turn-off Fall Time	t <sub>f</sub>			21			
Drain-Source Body Diode Characte	ristics						
Continuous Body Diode Current	۱ <sub>S</sub>	T 0500			160		
Pulsed Diode Forward Current	I <sub>SM</sub>	T <sub>C</sub> = 25°C			640	A	
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25°C, I <sub>SD</sub> = 20A, V <sub>GS</sub> = 0V			1.2	V	
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 20A,		62		ns	
Reverse Recovery Charge	Q <sub>rr</sub>	di <sub>F</sub> /dt = 500A/µs		74		nC	

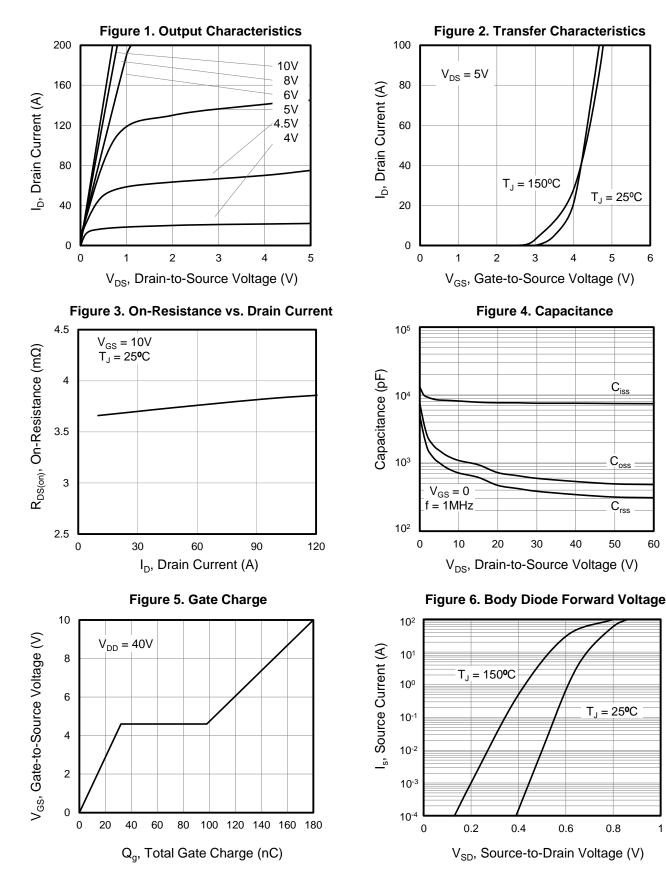
#### Notes

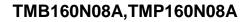
- 1. Repetitive Rating: Pulse Width limited by maximum junction temperature
- 2.  $I_{AS}$  = 80A,  $V_{DD}$  = 50V,  $R_{G}$  = 25 $\Omega$ , Starting  $T_{J}$  = 25°C
- 3. The power dissipation PD is based on TJ(MAX)=175 $^{\circ}$  C, using junction-to-case thermal resistance.

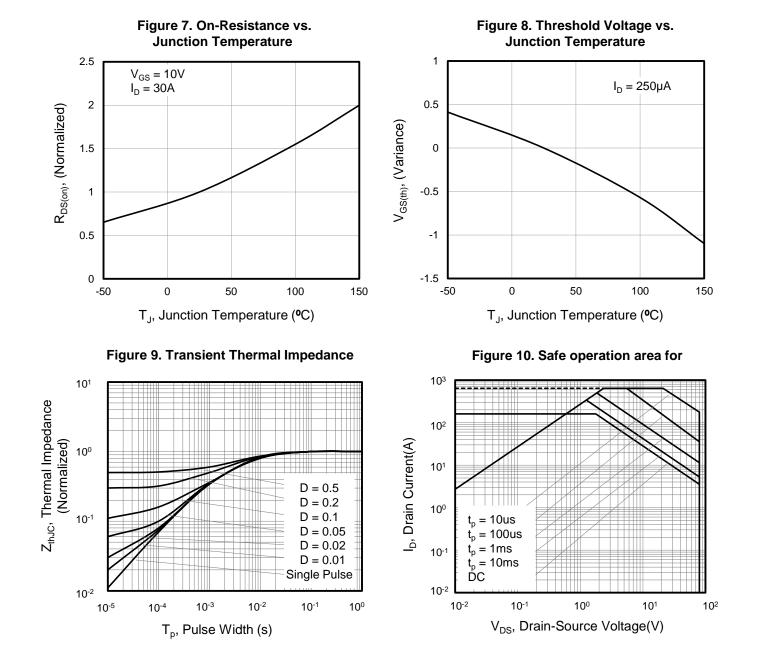












#### **Typical Characteristics** $T_J = 25^{\circ}C$ , unless otherwise noted



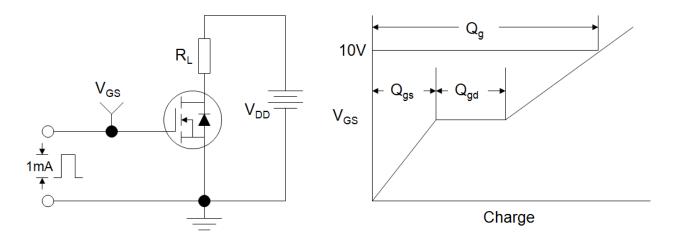


Figure B: Resistive Switching Test Circuit and Waveform

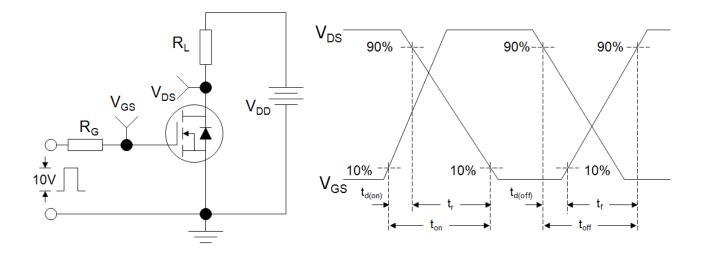
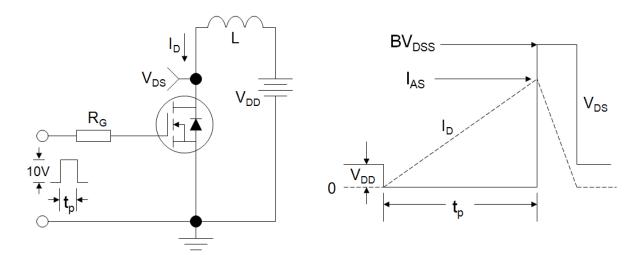
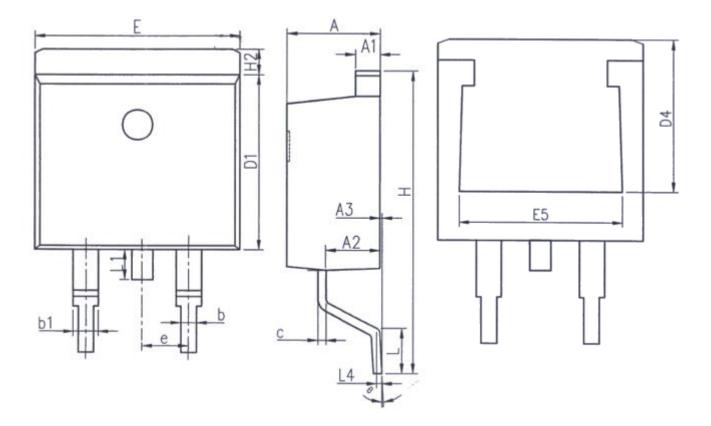


Figure C: Unclamped Inductive Switching Test Circuit and Waveform





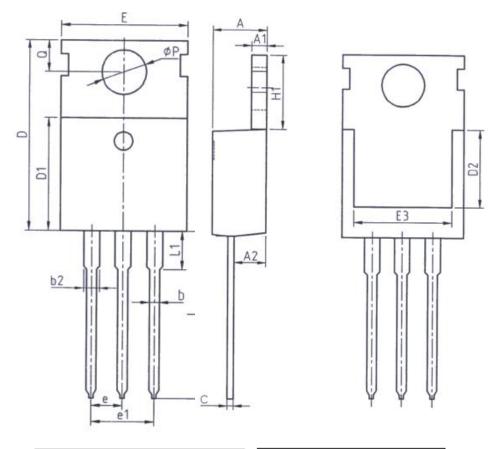
TO-263



	Unit: mm		l	Unit: mm	n
Symbol	Min.	Max.	Symbol	Min. Max	
Α	4. 37	4. 77	E	9.86	10.36
A1	1.22	1.42	E5	7.06	-
A2	2.49	2.89	e	2. 54BSC	
A3	0.00	0. 25	Н	14. 70	15. 50
b	0.70	0.96	H2	1.07	1.47
b1	1.17	1.47	L	2.00	2.60
с	0.30	0.53	L1	1.40	1.70
D1	8.50	8.90	L4	0. 25BSC	
D4	6. 60	-	θ	0°	<b>9</b> °



TO-220



Unit: mm			
Symbol	Min.	Max.	
Α	4. 37	4.77	
A1	1.25	1.45	
A2	2.20	2.60	
b	0.70	0.95	
b2	1.17	1.47	
C	0.40	0.65	
D	15.10	16. 10	
D1	8.80	9.40	
D2	5.50	-	

Unit: mm			
Symbol	Min. Max.		
E	9.70 10.3		
E3	7.00 -		
e	2. 54BSC		
e1	5. 08BSC		
H1	6. 25	6.85	
L	12.75	13.80	
L1	I	3. 40	
Ρ	3.40 3.80		
Q	2.60 3.00		



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